



MEASUREMENT OF THE $t\bar{t}$ PRODUCTION CROSS SECTION IN THE LEPTON + JETS CHANNEL USING JET PROBABILITY AT CDF

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Outline

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 - ◇ Why Lepton+Jets?
 - ◇ Why Jet Probability?
- Jet Probability tagger description
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- $t\bar{t}$ Cross Section Measurement

Motivation

- Why Top?

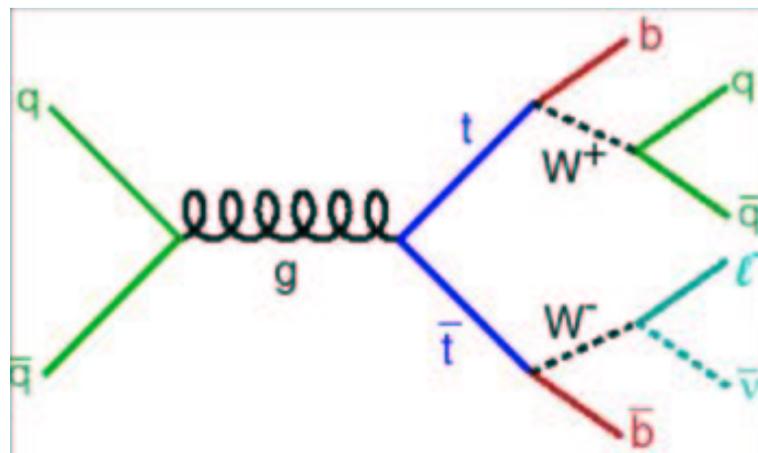
- Heaviest known fundamental particle \Rightarrow special role in EWSB
- Might be sensitive to Physics Beyond the Standard model
- Decays before it hadronizes due to its **yactosecond lifetime**
- Most recently discovered quark (1995, FNAL): detailed study with increased statistics

- Why Lepton+Jets?

- 1 lepton (electron or muon), ≥ 3 jets and high E_T
- S/B = 2/1 (Dilepton 4/1, All hadronic 1/4)
- BR = 30% (Dilepton 5%, All hadronic 44%)

- Why HF tagging?

- Top signal has 2 b's and only $\sim 1\%$ of the main backgrounds has HF \Rightarrow S/B greatly increased

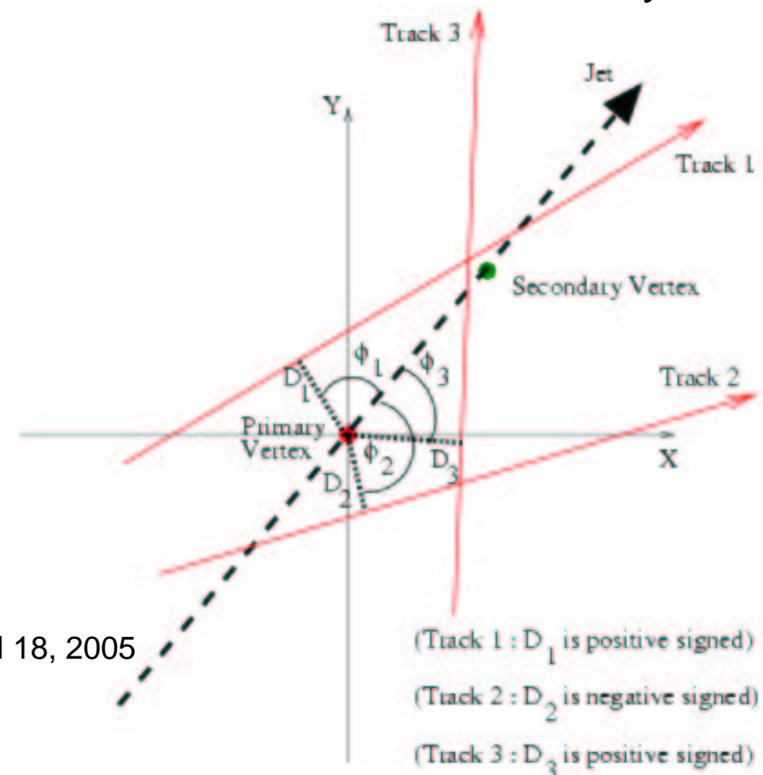
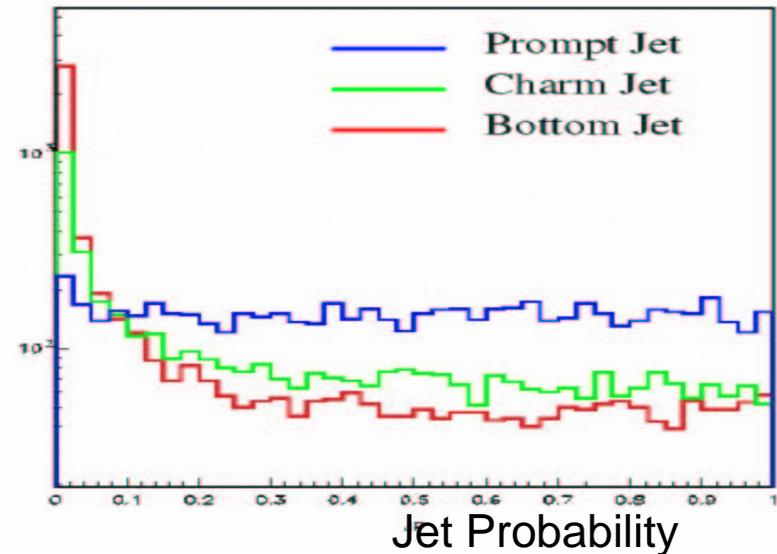


- Why Jet Probability?

- Measure $t\bar{t}$ x-section with a different tagging algorithm (SecVtx, SLT)
- JP provides (a priori) a more flexible way to understand the composition of the tagged sample by tuning the JP cut
- JP can be tuned/optimized differently for other kinds of analysis

Jet Probability Algorithm (I)

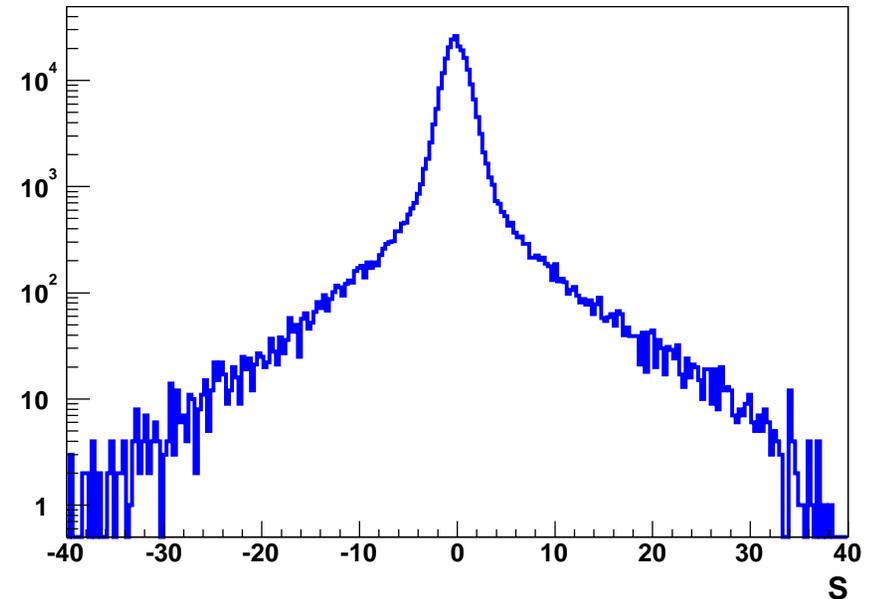
- Jet Probability is an algorithm to determine whether a jet has been produced at the primary interaction point or from the hadronization of a HF quark
- Physically, it represents the probability for a jet to come from the primary interaction vertex
- Uniform probability for light quark or gluon jets and peaks at 0 for jets containing displaced tracks from HF decays
- We use a signed impact parameter: $D > 0$ if point of closest approach to the primary vertex lies in the same direction as the jet direction ($\cos \phi > 0$)
- + (-) Jet Probability: only tracks with positive (negative) impact parameter



Jet Probability Algorithm (II)

- Track impact parameter significance: $S = D/\sigma_D$
- Fit the distribution of the track impact parameter significance to obtain a resolution function $R(S)$ (different for data and MC)
- Negative side of $R(S)$ used to determine the probability ($P_{tr}(S_0)$) that the impact parameter significance (S_0) of a given track is due to the detector resolution

$$P_{tr}(S_0) = \frac{\int_{-\infty}^{-|S_0|} R(S) dS}{\int_{-\infty}^0 R(S) dS}$$

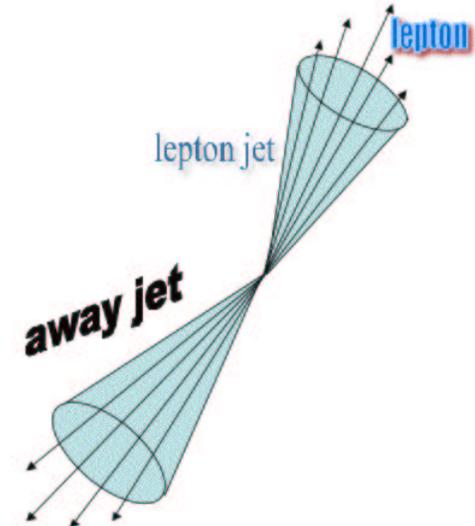


- The probability that a jet is consistent with a zero lifetime hypothesis is defined as

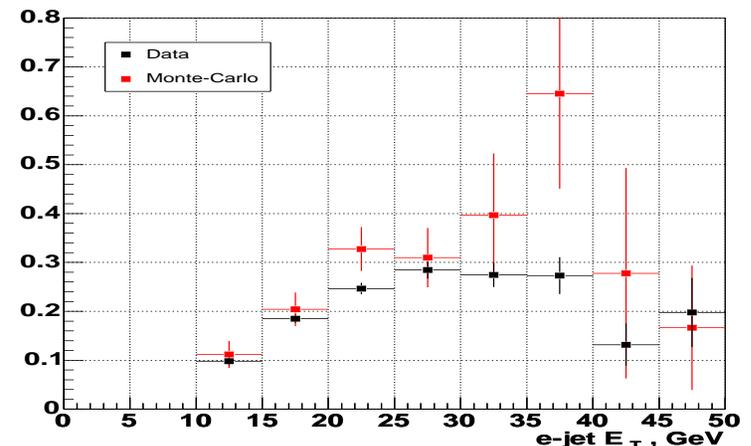
$$\prod_{l=1}^{N_{tr}} P_{tr} \times \sum_{k=0}^{N_{tr}-1} \frac{(-\ln \prod_{l=1}^{N_{tr}} P_{tr})^k}{k!}$$

Jet Probability Efficiency

- Measured using an 8 GeV inclusive electron data sample since it is enriched with HF due to the semiloptenic B decays
- **Single tag method:** $\epsilon = \frac{N_{ej}^+ - N_{ej}^-}{N_{ej}} \cdot \frac{1}{F_B}$
 - Disadvantage: relies on the correct determination of the heavy flavor fraction in the sample
- **Double tag method:** as HF quarks are mostly produced in pairs, HF content in one jet is enhanced requiring that the "other" jet (away jet) is tagged
- Since we use MC in the analysis, we also need to measure the efficiency in MC and then calculate the **Scale Factor** ($\epsilon^{data} / \epsilon^{MC}$)
- Efficiencies to tag a heavy flavor jet with $E_T > 10$ GeV and 162 pb^{-1}



Efficiency of Jet Probability Tagger, Jet Probability cut at 1%



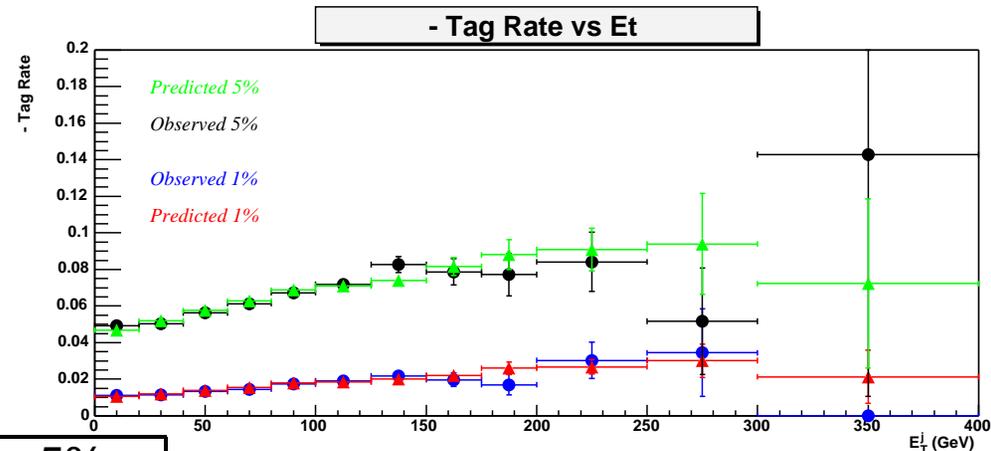
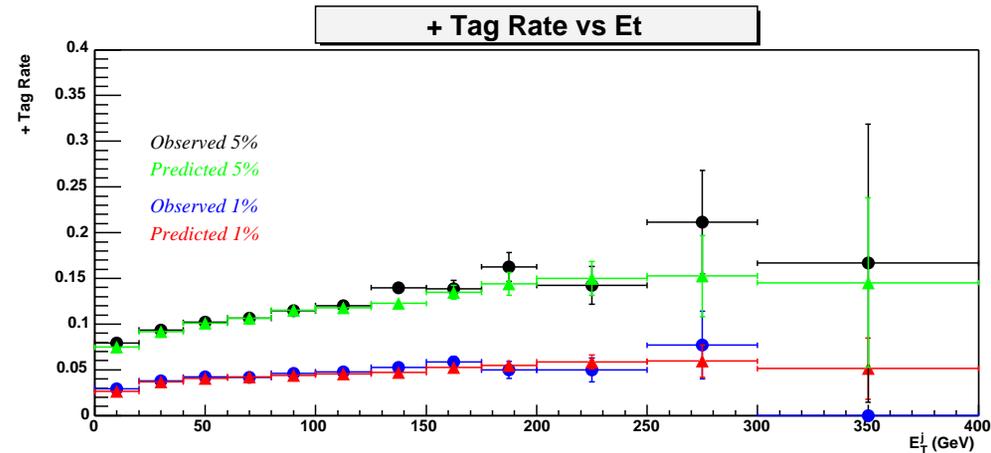
JP Efficiency vs E_T^{jet} (JP < 1%) in inclusive electron sample

	JP < 1%	JP < 5%
ϵ^{data}	0.197 ± 0.012	0.262 ± 0.013
ϵ^{MC}	0.250 ± 0.020	0.319 ± 0.023
Scale Factor	0.787 ± 0.105	0.820 ± 0.095

Jet Probability: MisTag Rate

- Determined using inclusive jet data samples with triggers thresholds of 20, 50, 70 and 100 GeV
- Parameterized as a 6 dimensional matrix of the following variables:
 $(E_T, N_{trk}, \sum E_T^j, \eta, Z_{vtx}, \phi)$
- Cross check: observed from the multijet trigger sample vs prediction from the inclusive jet data
- Results with 162 pb^{-1}

	JP < 1%	JP < 5%
Overall - tag rate (%)	1.11 ± 0.08	4.89 ± 0.19
Overall + tag rate (%)	3.22 ± 0.21	8.53 ± 0.34



$t\bar{t}$ Cross Section Measurement: Data Selection

- Counting experiment: $\sigma_{t\bar{t}} = \frac{N_{obs} - B_{bkg}}{\epsilon_{t\bar{t}} \times \int L dt}$
- Data sample based on Run II data (with Si) taken until September 03

	CEM (Central electrons, $ \eta < 1$)	CMUP (Central muons, $ \eta < 0.6$)	CMX (Extension muons, $0.6 < \eta < 1$)
Lum (pb^{-1})	161.6 ± 9.5	161.6 ± 9.5	149.8 ± 8.8

- Event selection:
 - 1 high p_T isolated lepton
 - high \cancel{E}_T
 - ≥ 3 energetic jets
 - ≥ 1 tagged jet (jet with positive JP < 0.01)

Jet Multiplicity	1 jet	2 jet	3 jet	≥ 4 jets
Pretag events				
CEM	7819	1202	201	61
CMUP	3758	587	81	27
CMX	1971	293	36	6
Total	13548	2082	318	94
Tagged events				
CEM	78	40	21	17
CMUP	40	30	8	10
CMX	13	11	2	1
Total	131	81	31	28

$t\bar{t}$ Cross Section Measurement: Acc. and Backg.

- JP tagging efficiencies for $t\bar{t}$ events (PYTHIA Monte Carlo sample with top mass $175 \text{ GeV}/c^2$)

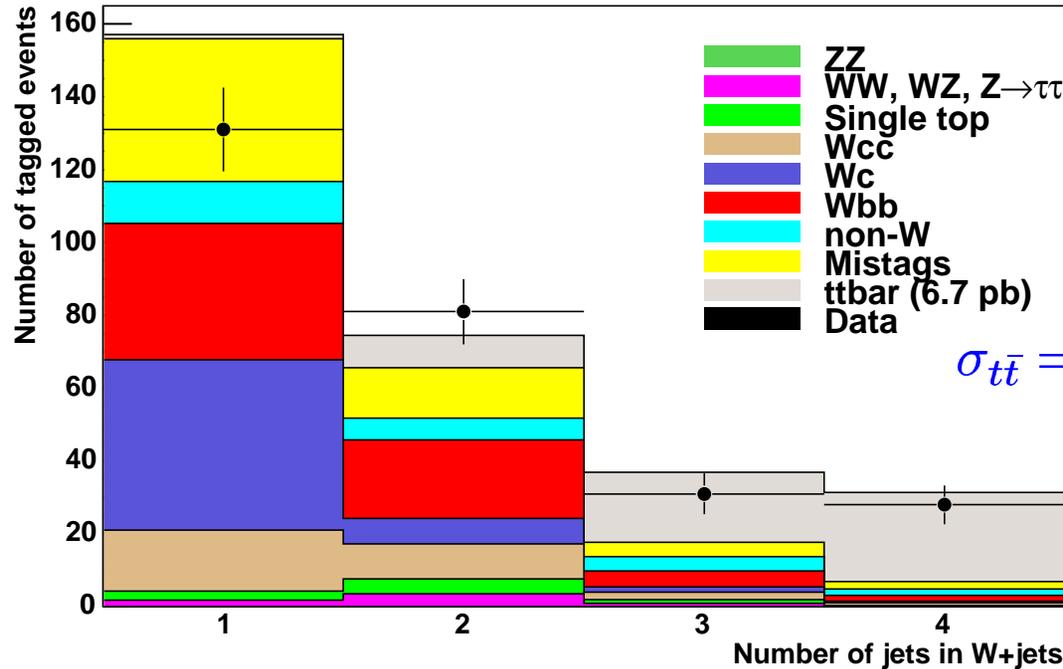
Quantity	CEM	CMUP	CMX
(SF = 0.787 ± 0.105)			
Acc. No Tag	$4.09 \pm 0.04 \pm 0.33$	$2.12 \pm 0.02 \pm 0.21$	$0.95 \pm 0.01 \pm 0.12$
Tag Eff	$56.99 \pm 0.28 \pm 6.66$	$56.88 \pm 0.36 \pm 6.67$	$57.84 \pm 0.60 \pm 6.67$
Average Tag Eff	$57.24 \pm 0.21 \pm 3.85$		
Acc. with Tag	$2.33 \pm 0.03 \pm 0.33$	$1.21 \pm 0.01 \pm 0.19$	$0.55 \pm 0.01 \pm 0.09$
$\epsilon_{t\bar{t}} \int L dt$	$3.77 \pm 0.23 \pm 0.58$	$1.95 \pm 0.12 \pm 0.32$	$0.82 \pm 0.05 \pm 0.15$

- Background estimate:
 - **Mistags**: predicted by the negative tag rate matrix
 - **non-W**: derived from the complementary regions of \cancel{E}_T vs lepton isolation
 - **W+HF**: estimated using W+HF MC to
 - extract the HF fractions from $\frac{W+HF}{W+Jets}$ MC and the b-tag efficiencies
 - normalized to W+jets pretag data
 - **Diboson**, $Z \rightarrow \tau\tau$ and **single top** derived from MC

$t\bar{t}$ Cross Section Measurement: Backg. Summary

Jet Multiplicity	1 jet	2 jet	3 jet	≥ 4 jets
MC Derived Backgrounds				
WW	0.753 ± 0.127	1.553 ± 0.259	0.437 ± 0.075	0.088 ± 0.017
WZ	0.539 ± 0.095	1.051 ± 0.180	0.319 ± 0.059	0.057 ± 0.015
ZZ	0.036 ± 0.008	0.078 ± 0.015	0.043 ± 0.009	0.009 ± 0.003
$Z\tau^+\tau^-$	0.473 ± 0.185	0.814 ± 0.256	0.172 ± 0.104	0.052 ± 0.053
Single Top (W^*)	0.538 ± 0.094	1.783 ± 0.312	0.558 ± 0.098	0.131 ± 0.024
Single Top (W -g)	1.907 ± 0.326	2.429 ± 0.414	0.498 ± 0.087	0.075 ± 0.015
Total	4.245 ± 0.774	7.708 ± 1.388	2.027 ± 0.382	0.412 ± 0.090
W + HF				
Wbb	37.52 ± 12.32	21.53 ± 6.80	4.43 ± 1.27	1.56 ± 0.50
Wc \bar{c}	16.77 ± 5.91	9.57 ± 1.96	1.96 ± 0.64	0.71 ± 0.25
Wc	46.74 ± 13.50	7.00 ± 2.06	1.48 ± 0.43	0.41 ± 0.13
Total	101.0 ± 29.5	38.10 ± 10.03	7.87 ± 1.99	2.69 ± 0.76
Others				
Mistag	$39.2^{+8.6}_{-2.6}$	$13.78^{+3.38}_{-1.65}$	$4.00^{+0.91}_{-0.24}$	$1.99^{+0.47}_{-0.15}$
Non W	11.41 ± 6.17	5.95 ± 3.29	3.86 ± 2.24	1.80 ± 1.17
Total Background	$155.85^{+31.70}_{-30.62}$	$65.53^{+11.83}_{-11.46}$	$17.76^{+3.28}_{-3.16}$	$6.89^{+1.50}_{-1.43}$
$t\bar{t}$ (6.7 pb^{-1})	1.18 ± 0.20	8.99 ± 1.53	19.10 ± 3.25	24.51 ± 4.17
DATA	131	81	31	28

$t\bar{t}$ Cross Section Measurement: Results



$$\sigma_{t\bar{t}} = 5.8_{-1.2}^{+1.3}(\text{stat}) \pm 1.3(\text{syst}) \text{ pb}$$

(Top mass $175 \text{ GeV}/c^2$)

- Correlations in acceptance, tagging scale factor and luminosity uncertainties
- Wbb and Wcc correlated across all the bins
- Rest of the errors treated as uncorrelated

Source	Fract. Syst. Uncert.	Contrib. to $\sigma_{t\bar{t}}$
MC Acceptance Modelling	8.7%	8.9%
Tagging Scale Factor (b's/c's)	13/20%	16.6%
Mistag Matrix Prediction	+20%	-3.1%
Non W Fraction	50%	0.8%
Non W Prediction	50%	7.4%
W+HF Prediction	30%	6.1%
MC derived (σ 's)	1.8%	0.1%
Luminosity	5.9%	6%
Total Syst. Uncert.		$\pm 22\%$

Summary

- We have described a tagging algorithm (JP) which is based on the information of the track impact parameter and that provides a continuous variable to discriminate HF jets
- We characterize the algorithm by measuring, from data, its efficiency and mistag rates. We obtain an efficiency of $57.24 \pm 3.86 \%$ for $t\bar{t}$ events (JP $< 1\%$)
- We use this algorithm in the Lepton+Jets sample to calculate the $t\bar{t}$ production cross section

$$\sigma = 5.8_{-1.2}^{+1.3}(stat) \pm 1.3(syst) \text{ (Top mass } 175\text{GeV}/c^2)$$

- The tagger algorithm is in place for the new sample of 318 pb^{-1} and the analysis is underway

BACK-UP SLIDES

Jet Probability Efficiency: Method

- Measured using an 8 GeV inclusive electron data sample and a generic 2→2 Herwig MonteCarlo sample

- **Single tag method:** $\epsilon = \frac{N_{ej}^+ - N_{ej}^-}{N_{ej}} \cdot \frac{1}{F_B}$

- Disadvantage: relies on the correct determination of the heavy flavor fraction in the sample

- **Double tag method:** sample of events with two jets

$$\epsilon = \frac{(N_{a+}^{e+} - N_{a+}^{e-}) - (N_{a-}^{e+} - N_{a-}^{e-})}{N_{a+} - N_{a-}} \cdot \frac{1}{F_B^a}$$

- Calculation of the heavy flavor content in the jet (F_B) has to be corrected for the contribution from charm (determined from MC): $F_B = F_b(1 + \lambda_{c/b})$

- F_b from $D^0 \rightarrow K\pi$ decays: $F_b = \frac{N_{D^0}}{N_{ej}} \cdot \frac{1}{\epsilon_{D^0}}$

- F_b from cascade muons: select b-hadrons with 2 semileptonic decays ($b \rightarrow c \rightarrow X$) emitting a pair e- μ with opposite charge:

$$F_b = \frac{1}{\epsilon_{\mu}} \frac{N_{ej}^{\mu}(OS) - N_{ej}^{\mu}(SS)}{N_{ej}}$$

Tag Rate Matrix Definition

Bin	E_T (GeV)	Trk. Mult.	$\sum E_T^{\text{jets}}$ (GeV)	$ \eta $	$ Z_{\text{vtx}} $ (cm)	ϕ
1	[0,20)	2	[0,80)	[0,1.0)	[0,10)	$[\frac{-\pi}{12}, \frac{\pi}{12})$
2	[20,35)	3	[80,140)	≥ 1.0	[10,20)	$[\frac{\pi}{12}, \frac{3\pi}{12})$
3	[35,50)	4,5	[140,220)		[20,40)	$[\frac{3\pi}{12}, \frac{5\pi}{12})$
4	[50,65)	6,7	≥ 220		[40,50)	$[\frac{5\pi}{12}, \frac{7\pi}{12})$
5	[65,80)	8,9			[50,60)	$[\frac{7\pi}{12}, \frac{9\pi}{12})$
6	[80,100)	10-13			≥ 60	$[\frac{9\pi}{12}, \frac{11\pi}{12})$
7	[100,120)	≥ 14				$[\frac{11\pi}{12}, \frac{13\pi}{12})$
8	[120,150)					$[\frac{13\pi}{12}, \frac{15\pi}{12})$
9	[150,180)					$[\frac{15\pi}{12}, \frac{17\pi}{12})$
10	≥ 180					$[\frac{17\pi}{12}, \frac{19\pi}{12})$
11						$[\frac{19\pi}{12}, \frac{21\pi}{12})$
12						$[\frac{21\pi}{12}, \frac{23\pi}{12})$